


<b>Search Notes</b>  	<b>Application/Control No.</b>  10594065	<b>Applicant(s)/Patent Under Reexamination</b>  TAKEUCHI ET AL.
	<b>Examiner</b>  VERNON P WEBB	<b>Art Unit</b>  2811

SEARCHED			
Class	Subclass	Date	Examiner
257	103	6/9/2008	V. Parris Webb

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted with Examiner Andrew Arena	6/18/2008	V. Parris Webb

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner